

Notice of References Cited	Application/Control No. 10/583,374		Applicant(s)/Patent Under Reexamination YAMAUCHI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0142430	06-2005	Yoshida et al.	429/044
*	B	US-2005/0233203	10-2005	Hampden-Smith et al.	429/044
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 03/081700	10-2003	WIPO	Yoshida et al.	H01M 4/86
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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